

<b>Notice of References Cited</b>	Application/Control No. 10/605,252	Applicant(s)/Patent Under Reexamination LIN ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2001/0009366	07-2001	Kono et al.	324/207.2
	B	US-4,657,451	04-1987	Tanaka, Yuzuru	409/186
	C	US-3,849,724	11-1974	Ghibu et al.	324/207.14
	D	US-4,401,945	08-1983	Juengel, Richard O.	324/207.14
	E	US-4,408,933	10-1983	Tomita et al.	408/8
	F	US-4,000,448	12-1976	Shum et al.	318/39
	G	US-4,878,020	10-1989	Karna et al.	324/207.17
	H	US-3,902,114	08-1975	Alich, Gunther	324/224
	I	US-6,060,880	05-2000	Guyot et al.	324/207.2
	J	US-5,521,497	05-1996	Schneider et al.	324/207.22
	K	US-6,681,659	01-2004	Hoe et al.	81/54
	L	US-6,600,310	07-2003	Nyce et al.	324/207.23
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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